



Designation: D3084 – 05

Standard Practice for Alpha-Particle Spectrometry of Water¹

This standard is issued under the fixed designation D3084; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reappraisal. A superscript epsilon (ϵ) indicates an editorial change since the last revision or reappraisal.

1. Scope

1.1 This practice covers the processes that are required to obtain well-resolved alpha-particle spectra from water samples and discusses associated problems. This practice is generally combined with specific chemical separations, mounting techniques, and counting instrumentation, as referenced.

1.2 *This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use.*

2. Referenced Documents

2.1 *ASTM Standards:*²

C859 Terminology Relating to Nuclear Materials

C1163 Practice for Mounting Actinides for Alpha Spectrometry Using Neodymium Fluoride

D1129 Terminology Relating to Water

D3648 Practices for the Measurement of Radioactivity

D3865 Test Method for Plutonium in Water

D3972 Test Method for Isotopic Uranium in Water by Radiochemistry

3. Terminology

3.1 For definitions of terms used in this practice, refer to Terminologies **D1129** and **C859**. For terms not found in these terminologies, reference may be made to other published glossaries (**1**, **2**).³

4. Summary of Practice

4.1 Alpha-particle spectrometry of radionuclides in water (also called alpha-particle pulse-height analysis) has been

carried out by several methods involving magnetic spectrometers, gas counters, scintillation spectrometers, nuclear emulsion plates, cloud chambers, absorption techniques, and solid-state counters. Gas counters, operating either as an ionization chamber or in the proportional region, have been widely used to identify and measure the relative amounts of different α -emitters. However, more recently, the solid-state counter has become the predominant system because of its excellent resolution and compactness. Knoll (**3**) extensively discusses the characteristics of both detector types.

4.2 Of the two gas-counting techniques, the pulsed ionization chamber is more widely used as it gives much better resolution than does the other. This is because there is no spread arising from multiplication or from imperfection of the wire such as occurs with the proportional counter.

4.3 The semiconductor detectors used for alpha-particle spectrometry are similar in principle to ionization chambers. The ionization of the gas by α -particles gives rise to electron-ion pairs, while in a semiconductor detector, electron-hole pairs are produced. Subsequently, the liberated charges are collected by an electric field. In general, silicon detectors are used for alpha-particle spectrometry. These detectors are *n*-type base material upon which gold is evaporated or ions such as boron are implanted, making an electrical contact. A reversed bias is applied to the detector to reduce the leakage current and to create a depletion layer of free-charge carriers. This layer is thin and the leakage current is very low. Therefore, the slight interactions of photons with the detector produce no signal. The effect of any interactions of beta particles with the detector can be eliminated by appropriate electronic discrimination (gating) of signals entering the multichannel analyzer. A semiconductor detector detects all alpha particles emitted by radionuclides (approximately 2 to 10 MeV) with essentially equal efficiency, which simplifies its calibration.

4.4 Semiconductor detectors have better resolution than gas detectors because the average energy required to produce an electron-hole pair in silicon is 3.5 ± 0.1 eV (0.56 ± 0.02 aJ) compared with from 25 to 30 eV (4.0 to 4.8 aJ) to produce an ion pair in a gas ionization chamber. Detector resolution, defined as peak full-width at half-maximum height (FWHM), is customarily expressed in kiloelectron-volts. The FWHM increases with increasing detector area, but is typically between 15 and 60 keV. The background is normally lower for a

¹ This practice is under the jurisdiction of ASTM Committee **D19** on Water and is the direct responsibility of Subcommittee **D19.04** on Methods of Radiochemical Analysis.

Current edition approved Jan. 1, 2005. Published January 2005. Originally approved in 1972. Last previous edition approved in 1996 as D3084 – 96. DOI: 10.1520/D3084-05.

² For referenced ASTM standards, visit the ASTM website, www.astm.org, or contact ASTM Customer Service at service@astm.org. For *Annual Book of ASTM Standards* volume information, refer to the standard's Document Summary page on the ASTM website.

³ The boldface numbers in parentheses refer to the list of references at the end of this document.

semiconductor detector than for ionization chamber. Silicon detectors have four other advantages compared to ionization chambers: they are lower in cost, have superior stability, have higher permissible counting rates, and have better time resolution for coincidence measurements. However, the semiconductor detector requires sophisticated electronics because of the low charge that is generated by the incident α -particle in the detector. Low-noise and high-stability, charge-sensitive preamplifiers are used prior to the detection, analog-to-digital conversion, and storage of the voltage pulse by a multichannel analyzer. The counting is nearly always performed in a vacuum chamber so that the α -particles will not lose energy by collisions with air molecules between the source and the detector.

4.5 A gridded pulse-ionization chamber was developed by Frisch for high-resolution alpha spectrometry. The unit consists of a standard ionization chamber fitted with a collimator between the source and the collector plate and a wire grid to shield the collector from the effects of positive ions. The resolution of a gridded pulse ionization chamber is from 35 to 100 keV for routine work. The detector parameters that affect resolution are primarily the following: statistical variations in the number of ion pairs formed at a given alpha energy, the variation in rise time of pulses, and the effects of positive ions. An advantage of gridded ionization chambers is their ability to count large-area sources with good efficiency.

4.6 There are two reasons for collimating a sample in a gridded ionization chamber. When thick-sample sources are encountered, the alpha-particles emitted at a large solid angle would show an energy degradation upon ionization of the gas. The effect leads to tailing of the alpha-particle spectrum. This problem is reduced significantly by use of the collimator. Secondly, when the nucleus following an α -particle emission does not decay to a ground state, the γ -rays that may be produced are usually highly converted, and the conversion electrons ionize the gas. The special mesh-type collimators stop the conversion electrons and collimate the source simultaneously.

4.7 A more recently developed measurement method is photon-electron-rejecting alpha liquid-scintillation spectrometry. The sample is counted in a special liquid-scintillation spectrometer that discriminates electronically against non-alpha-particle pulses. The resolution that can be achieved by this method is 250 to 300-keV FWHM. This is superior to conventional liquid-scintillation counting, but inferior to silicon detectors and gridded pulse-ionization chambers. An application of this method is given in Ref 4.

5. Significance and Use

5.1 Alpha-particle spectrometry can either be used as a quantitative counting technique or as a qualitative method for informing the analyst of the purity of a given sample.

5.2 The method may be used for evaporated alpha-particle sources, but the quality of the spectra obtained will be limited by the absorbing material on the planchet and the surface finish of the planchet.

6. Interferences

6.1 The resolution or ability to separate alpha-particle peaks will depend on the quality of the detector, the pressure inside the counting chamber, the source-to-detector distance, the instrumentation, and the quality of the source. If peaks overlap, a better spectrometer or additional chemical separations will be required.

7. Apparatus

7.1 *Alpha Particle Detector*, either a silicon semiconductor or a Frisch-grid pulse-ionization chamber.

7.2 *Counting Chamber*, to house the detector, hold the source, and allow the detector system to be evacuated.

7.3 *Counting Gas*, for ionization chamber, typically a 90 % argon–10 % methane mixture, and associated gas-handling equipment.

7.4 *Pulse Amplification System*, possibly including a preamplifier, amplifier, postamplifier, pulse stretcher, and a high-voltage power supply, as directed by the quality and type of detector employed.

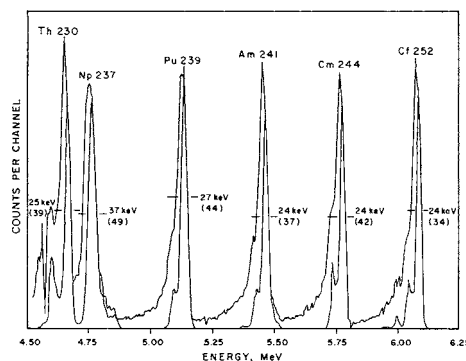
7.5 *Multichannel Pulse-Height Analyzer*, including data readout equipment. This is now often computer based.

7.6 *Vacuum Pump*, with low vapor-pressure oil and preferably with a trap to protect the detector from oil vapors.

8. Source Preparation

8.1 The technique employed for preparing the source should produce a low-mass, uniformly distributed deposit that is on a very smooth surface. The three techniques that are generally employed are electrodeposition, microcoprecipitation, and evaporation. The first two usually are preferred. Fig. 1 compares the alpha-particle spectrum of an electrodeposited source with that of an evaporated source.

8.1.1 Electrodeposition of α -emitters can provide a sample with optimum resolution, but quantitative deposition is not necessarily achieved. Basically, the α -emitter is deposited from solution on a polished stainless steel or platinum disk, which is the cathode. The anode is normally made from platinum gauze or a spiralled platinum wire, which often is rotated at a constant rate. Variants of this technique may be found in Refs 5 and 6.



NOTE 1—Inner curve: nuclides separated on barium sulfate and then electrodeposited.

NOTE 2—Outer curve: carrier-free tracer solution evaporated directly.

FIG. 1 Resolution Obtained on Six-Component Mixture

See also Test Method **D3865**. Polonium can be made to deposit spontaneously from solution onto a copper or nickel disk (7).

8.1.2 Micro-coprecipitation of actinide elements on a rare-earth fluoride, often neodymium fluoride, followed by filtration on a specially prepared membrane-type filter (see Test Method **C1163**) also produces a good-quality source for alpha-particle spectrometry. The microgram quantity of precipitant only slightly degrades spectral resolution.

8.1.3 The evaporation technique involves depositing the solution onto a stainless steel or platinum disk. The liquid is applied in small droplets over the entire surface area so that they dry separately, or a wetting agent is applied, which causes the solution to evaporate uniformly over the entire surface. The total mass should not exceed $10\mu\text{ g/cm}^2$, otherwise self-absorption losses will be significant. In addition, the alpha-particle spectrum will be poorly resolved, as evidenced by a long lower-energy edge on the peak. This tailing effect can contribute counts to lower energy alpha peaks and create large uncertainties in peak areas. Alpha sources that are prepared by evaporation may not adhere tenaciously and, therefore, can flake causing contamination of equipment and sample losses.

9. Calibration

9.1 Calibrate the counter by measuring α -emitting radionuclides that have been prepared by one of the techniques described in Section 8. All standards should be traceable to the National Institute of Standards and Technology and in the case of nonquantitative mounting, standardized on a 2π or 4π alpha-particle counter. Precautions should be taken to ensure that significant impurities are not present when standardizing the alpha-particle activity by non-spectrometric means. The physical characteristics of the calibrating sources and their positioning relative to the detector must be the same as the samples to be counted. A mixed radionuclide standard can be counted to measure simultaneously the detector resolution and efficiency, and the gain of the multichannel analyzer. Check the instrumentation frequently for consistent operation. Perform background measurements regularly and evaluate the results at the confidence level desired.

10. Procedure

10.1 The procedure of analysis is dependent upon the radionuclide(s) of interest. A chemical procedure is usually required to isolate and purify the radionuclides. See Test Methods **D3865** and **D3972**. Additional appropriate chemical procedures may be found in Refs (789–10). A source is then prepared by a technique in accordance with Section 8. Measure the radioactivity of this source in an alpha spectrometer, following the manufacturer’s operating instructions. The counting period chosen depends on the sensitivity required of the measurement and the degree of uncertainty in the result that is acceptable (see Section 12).

10.2 Silicon detectors will eventually become contaminated by recoiling atoms unless protective steps are taken. Controlling the air pressure in the counting chamber so that $12\mu\text{g/cm}^2$ of absorber is present between the source and the detector will cause only a 1-keV resolution loss; however, the recoil contamination will be reduced by a factor greater than 500.

Recoiling atoms can also be reduced electrically (11). Ruggedized detectors can be cleaned to a limited degree.

10.3 Qualitative identifications sometimes can be made even on highly degraded spectra. By examining the highest energy value, and using the energy calibration (keV/channel) of the pulse-height analyzer, alpha-particle emitters may be identified. Fig. 2 shows a typical spectrum with very poor resolution.

11. Calculation

11.1 Analyze the data by first integrating the area under the alpha peak to obtain a gross count for the alpha emitter. When the spectrum is complex and alpha peaks add to each other, corrections for overlapping peaks will be required. Some instrument manufacturer’s computer software can perform these and other data-analysis functions.

11.2 The preferred method for determination of chemical recovery is the use of another isotope of the same element (examples: polonium-208 to trace polonium-210, plutonium-236 to trace plutonium-239, and americium-243 to trace americium-241). Add a known activity of the appropriate isotope(s) to the sample at the beginning of the analysis, perform the appropriate chemical separations, mount the sample, and measure it by alpha-particle spectrometry. The chemical yield is directly related to the reduction in the activity of the added isotope.

11.2.1 When the recovery factor is determined by the addition of a tracer, calculate the gross radioactivity concentration, C , of the analyte in becquerels per litre (Bq/L) as follows:

11.2.1.1 Radiotracer Net Counts:

$$N_T = G_T - B_C - I \quad (1)$$

$$\sigma_{NT} = \left[G_T + I + B \times \left(\frac{t_S}{t_B} \right)^2 \right]^{1/2} \quad (2)$$

where:

- N_T = net counts in the tracer region of interest,
- G_T = gross counts in the tracer region of interest,
- B_C = background counts in the region of interest corrected for sample count time,
- σ_{NT} = one-sigma uncertainty of the net tracer counts,

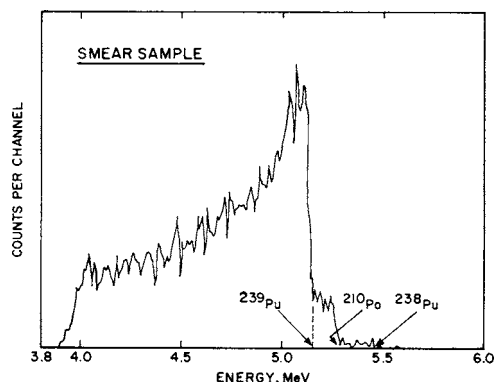


FIG. 2 Poor Resolution Alpha-Spectrum Containing Minor Components at Higher Energies